



Edition 1.0 2025-06

# INTERNATIONAL STANDARD

Electronic displays – iTeh Standards
Part 2-8: Measurements of optical characteristics – Reflective displays
(https://standards.iteh.ai)
Document Preview

<u>1EC 62977-2-8:2025</u>

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EC 62977-2-8:2025-06(er

ICS 31.120; 31.260 ISBN 978-2-8327-0416-5



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IEC Secretariat Tel.: +41 22 919 02 11

3, rue de Varembé info@iec.ch CH-1211 Geneva 20 www.iec.ch

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## Part-2-8: Measurements of optical characteristics -Reflective displays

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The text of this International Standard is based on the following documents:

Draft	Report on voting
110/1745/FDIS	110/1764/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

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